

# BIPOLAR ANALOG INTEGRATED CIRCUIT $\mu$ PC29M33A, $\mu$ PC29M05A

### THREE-TERMINAL LOW DROPOUT VOLTAGE REGULATOR

#### DESCRIPTION

The  $\mu$ PC29M33A,  $\mu$ PC29M05A of low dropout voltage three terminal positive regulators is constructed with PNP output transistor. The  $\mu$ PC29M33A,  $\mu$ PC29M05A feature the ability to source 0.5 A of output current with a low dropout voltage of typically 0.5 V.

The power dissipation of the  $\mu$ PC29M33A,  $\mu$ PC29M05A can be drastically reduced compared with the conventional three terminal positive voltage regulators that is constructed with NPN output transistor. Also, this series corresponds to the low voltage output (3 V, 3.3 V) which is not in the conventional low dropout regulators ( $\mu$ PC24M00A series).

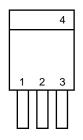
#### **FEATURES**

- Output current in excess of 0.5 A
- Low dropout voltage VDIF = 0.5 V TYP. (at Io = 0.5 A)
- On-chip overcurrent and thermal protection circuit
- On-chip output transistor safe area protection circuit

#### PIN CONFIGURATION (Marking Side)

 $\mu$ PC29M33AHF,  $\mu$ PC29M05AHF: MP-45G

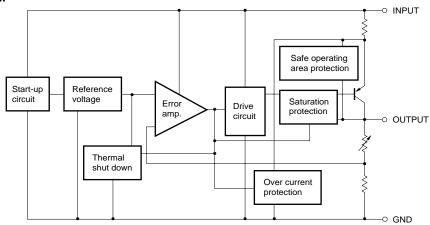
1 2 3 1: INPUT 2: GND 3: OUTPUT  $\mu$ PC29M33AHB,  $\mu$ PC29M05AHB: MP-3  $\mu$ PC29M33A,  $\mu$ PC29M05AT: MP-3Z



1: INPUT 2: GND 3: OUTPUT 4: GND (Fin)

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## **BLOCK DIAGRAM**



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# **ORDERING INFORMATION**

Part Number	Package	Output Voltage	Marking	Package Type
$\mu$ PC29M33AHF	MP-45G	3.3 V	29M33A	Packed in envelope
	(Isolated TO-220)			
$\mu$ PC29M33AHB	MP-3 (SC-64)	3.3 V	29M33A	Packed in envelope
μPC29M33AT	MP-3Z (SC-63)	3.3 V	29M33A	Packed in envelope
μPC29M33AT-E1	MP-3Z (SC-63)	3.3 V	29M33A	16 mm wide embossed taping
				Pin 1 on drawout side
				• 2000 pcs/reel
μPC29M33AT -E2	MP-3Z (SC-63)	3.3 V	29M33A	16 mm width embossed taping
				Pin 1 at takeup side
				• 2000 pcs/reel
μPC29M33AT -T1	MP-3Z (SC-63)	3.3 V	29M33A	32 mm wide adhesive taping
				Pin 1 at drawout side
				• 1500 pcs/reel
$\mu$ PC29M33AT -T2	MP-3Z (SC-63)	3.3 V	29M33A	• 32 mm wide adhesive taping
				Pin 1 at takeup side
				• 1500 pcs/reel
$\mu$ PC29M05AHF	MP-45G	5.0 V	29M05A	Packed in envelope
	(Isolated TO-220)			
$\mu$ PC29M05AHB	MP-3 (SC-64)	5.0 V	29M05A	Packed in envelope
$\mu$ PC29M05AT	MP-3Z (SC-63)	5.0 V	29M05A	Packed in envelope
μPC2905AT-E1	MP-3Z (SC-63)	5.0 V	29M05A	• 16 mm wide embossed taping
				Pin 1 at drawout side
				• 2000 pcs/reel
μPC2905AT-E2	MP-3Z (SC-63)	5.0 V	29M05A	• 16 mm wide embossed taping
				Pin 1 at takeup side
				• 2000 pcs/reel
μPC2905AT-T1	MP-3Z (SC-63)	5.0 V	29M05A	32 mm wide adhesive taping
				Pin 1 at drawout side
				• 1500 pcs/reel
μPC2905AT-T2	MP-3Z (SC-63)	5.0 V	29M05A	32 mm wide adhesive taping
				Pin 1 at takeup side
				• 1500 pcs/reel

### ABSOLUTE MAXIMUM RATINGS (TA = 25°C unless otherwise specified)

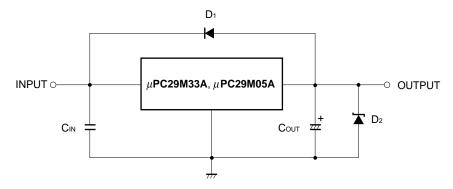
		Rat		
Parameter	Symbol	μPC29M33AHF,	μРС29М33АНВ, μРС29М05АНВ	Unit
		μPC29M05AHF	μPC29M33AT, μPC29M05AT	
Input Voltage	Vin	20		V
Internal Power Dissipation Note (Tc = 25°C)	Рт	15	10	W
Operating Ambient Temperature	TA	-30 to +85		°C
Operating Junction Temperature	TJ	-30 to +150		°C
Storage Temperature	T <sub>stg</sub>	–55 to	+150	°C
Thermal Resistance (junction to case)	Rth(J-C)	7 12.5		°C/W
Thermal Resistance (junction to ambient)	Rth(J-A)	65	125	°C/W

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**Note** Internally limited. When the operating junction temperature rises over 150°C, the internal circuit shuts down the output voltage.

Caution If the absolute maximum rating of any of the above parameters is exceeded even momentarily, the quality of the product may be degraded. In other words, absolute maximum ratings specify the values exceeding which the product may be physically damaged. Be sure to use the product with these ratings never exceeded.

#### STANDARD CONNECTION



C<sub>IN</sub>:  $0.1~\mu\text{F}$  or higher. Set this value according to the length of the line between the regulator and INPUT pin. Be sure to connect C<sub>IN</sub> to prevent parasitic oscillation. Use of a film capacitor or other capacitor with excellent voltage and temperature characteristics is recommended. If using a laminated ceramic capacitor, it is necessary to ensure that C<sub>IN</sub> is  $0.1~\mu\text{F}$  or higher for the voltage and temperature range to be used.

Cout: 47  $\mu$ F or higher. Be sure to connect Cout to prevent oscillation and improve excessive load regulation. Place CIN and Cout as close as possible to the IC pins (within 2 cm). Also, use an electrolytic capacitor with low impedance characteristics if considering use at sub-zero temperatures.

D<sub>1</sub>: If the OUTPUT pin has a higher voltage than the INPUT pin, connect a diode.

D2: If the OUTPUT pin has a lower voltage than the GND pin, connect a Schottky barrier diode.

Caution Make sure that no voltage is applied to the OUTPUT pin from external.



### RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Type Number	MIN.	TYP.	MAX.	Unit
Input Voltage	Vin	/IN μPC29M33A			16	V
		μPC29M05A	6		16	
Output Current	lo	All	0		0.5	Α
Operating Ambient Temperature	TA	All	-30		+85	°C
Operating Junction Temperature	ΤJ	All	-30		+125	°C

## **ELECTRICAL CHARACTERISTICS**

 $\mu$ PC29M33A (T<sub>J</sub> = 25°C, V<sub>IN</sub> = 5 V, Io = 350 mA, C<sub>IN</sub> = 0.22  $\mu$ F, Cout = 47  $\mu$ F, unless otherwise specified)

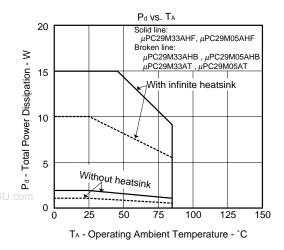
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output Voltage	Vo		3.18	3.3	3.42	V
		$0^{\circ}C \leq T_{J} \leq 125^{\circ}C,~4.3~V \leq V_{IN} \leq 16~V,$ $0~A \leq I_{O} \leq 350~mA$	3.14		3.46	
		$0^{\circ}C \le T_{J} \le 125^{\circ}C, \ 0 \ A \le I_{O} \le 0.5 \ A$	]			
Line Regulation	REGIN	4.3 V ≤ V <sub>IN</sub> ≤ 16 V		8	33	mV
Load Regulation	REG∟	0 A ≤ Io ≤ 0.5 A		10	33	
Quiescent Current	IBIAS	Io = 0 A		1.8	3.0	mA
		Io = 0.5 A		15	20	
Startup Quiescent Current	BIAS (s)	V <sub>IN</sub> = 3.1 V, Io = 0 A		9	20	mA
		V <sub>IN</sub> = 3.1 V, Io = 0.5 A			50	
Quiescent Current Change	$\Delta {\sf I}$ bias	$0^{\circ}C \le T_J \le 125^{\circ}C, \ 4.3 \ V \le V_{IN} \le 16 \ V$		2.9	15	mA
Output Noise Voltage	Vn	10 Hz ≤ f ≤ 100 kHz		56		$\mu$ Vr.m.s.
Ripple Rejection	R•R	$4.3 \text{ V} \le \text{V}_{\text{IN}} \le 16 \text{ V}, \text{ f} = 120 \text{ Hz}$	48	64		dB
Dropout Voltage	VDIF	0°C ≤ T <sub>J</sub> ≤ 125°C, lo = 0.5 A		0.5	1.0	V
Short Circuit Current	lOpeak	V <sub>IN</sub> = 4.5 V	0.7	1.1	1.5	Α
		V <sub>IN</sub> = 16 V		0.6		
Peak Output Current	lOpeak	V <sub>IN</sub> = 4.5 V	0.7	1.2	1.5	Α
		V <sub>IN</sub> = 16 V	0.6	1.0	1.5	]
Temperature Coefficient of Output Voltage	ΔVo /ΔΤ	0°C ≤ T <sub>J</sub> ≤ 125°C, lo = 5 mA		-0.4		mV/°C

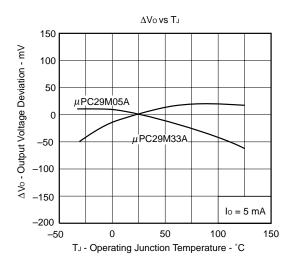
# $\mu$ PC29M05A (T<sub>J</sub> = 25°C, V<sub>IN</sub> = 8 V, Io = 350 mA, C<sub>IN</sub> = 0.22 $\mu$ F, C<sub>OUT</sub> = 47 $\mu$ F, unless otherwise specified)

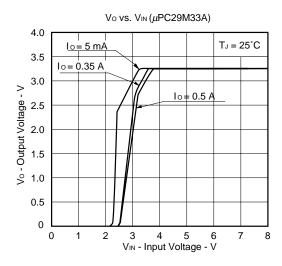
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output Voltage	Vo		4.83	5.0	5.18	V
		$0^{\circ}C \leq T_{J} \leq 125^{\circ}C, \ 6 \ V \leq V_{IN} \leq 16 \ V,$ $0 \ A \leq I_{O} \leq 350 \ mA$	4.75		5.25	
		$0^{\circ}C \le T_{J} \le 125^{\circ}C, \ 0 \ A \le I_{O} \le 0.5 \ A$				
Line Regulation	REGIN	6 V ≤ V <sub>IN</sub> ≤ 16 V		26	50	mV
Load Regulation	REG∟	0 A ≤ Io ≤ 0.5 A		17	50	mV
Quiescent Current	IBIAS	Io = 0 A		1.9	4.0	mA
		Io = 0.5 A		15	20	
Startup Quiescent Current	IBIAS (s)	V <sub>IN</sub> = 4.5 V, Io = 0 A		10	20	mA
		V <sub>IN</sub> = 4.5 V, Io = 0.5 A			50	
Quiescent Current Change	$\Delta I$ bias	$0^{\circ}C \le T_{J} \le 125^{\circ}C, 6 \text{ V} \le V_{IN} \le 16 \text{ V}$		2.4	15	mA
Output Noise Voltage	Vn	10 Hz ≤ f ≤ 100 kHz		87		$\mu$ Vr.m.s.
Ripple Rejection	R•R	6 V ≤ V <sub>IN</sub> ≤ 16 V, f = 120 Hz	46	60		dB
Dropout Voltage	V <sub>DIF</sub>	0°C ≤ T <sub>J</sub> ≤ 125°C, lo = 0.5 A		0.5	1.0	V
Short Circuit Current	lOpeak	V <sub>IN</sub> = 6.5 V	0.65	1.1	1.5	Α
		V <sub>IN</sub> = 16 V		0.6		
Peak Output Current	lOpeak	V <sub>IN</sub> = 6.5 V	0.7	1.2	1.5	Α
		V <sub>IN</sub> = 16 V	0.6	1.1	1.5	
Temperature Coefficient of Output Voltage	ΔVο /ΔΤ	0°C ≤ TJ ≤ 125°C, lo = 5 mA		0.7		mV/°C

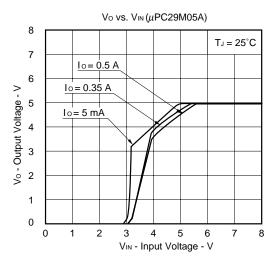
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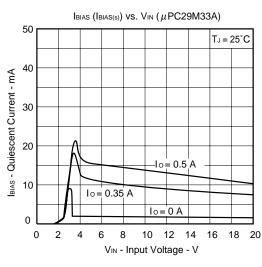
## TYPICAL CHARACTERISTICS (Reference Values)

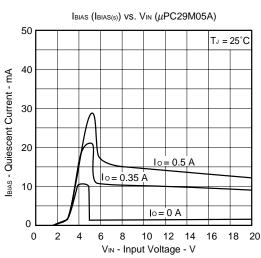


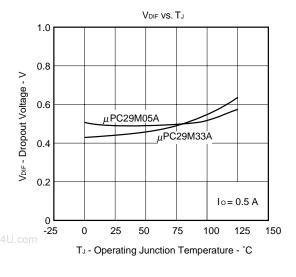


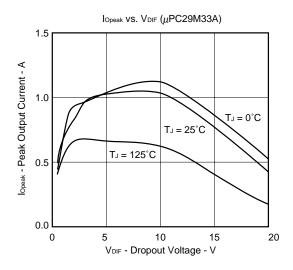


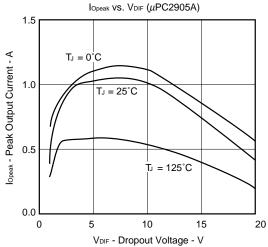


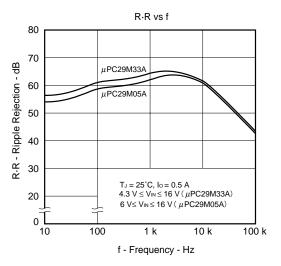


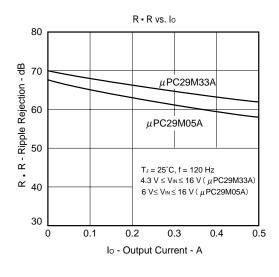


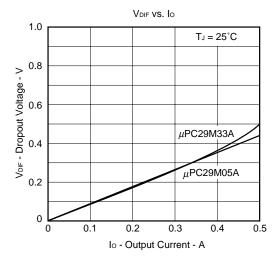


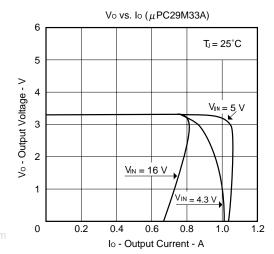


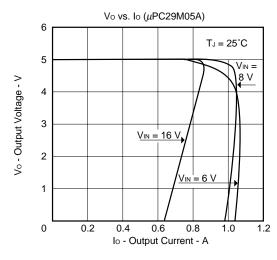










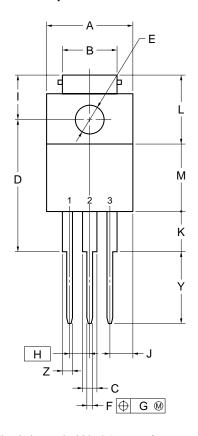


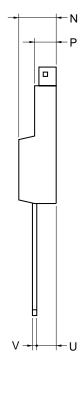
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### **PACKAGE DRAWINGS**

## $\mu$ PC29M33AHF, $\mu$ PC29M05AHF

# 3PIN PLASTIC SIP (MP-45G)





### NOTE

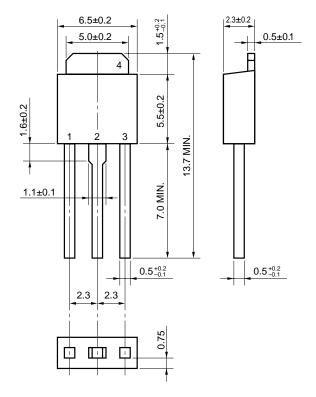
Each lead centerline is located within 0.25 mm of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS
Α	10.0±0.2
В	7.0±0.2
С	1.50±0.2
D	17.0±0.3
Е	φ3.3±0.2
F	0.75±0.10
G	0.25
Н	2.54 (T.P.)
- 1	5.0±0.3
J	2.46±0.2
K	5.0±0.2
L	8.5±0.2
М	8.5±0.2
N	4.5±0.2
Р	2.8±0.2
U	2.4±0.5
V	0.65±0.10
Υ	8.9±0.7
Z	1.30±0.2

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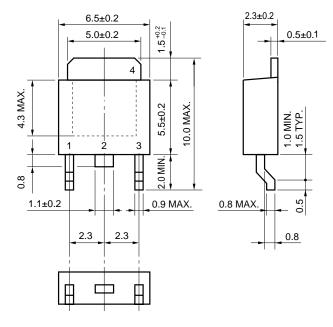
# $\mu$ PC29M33AHB, $\mu$ PC29M05AHB

MP-3(SC-64) (Unit: mm)



# $\mu$ PC29M33AT, $\mu$ PC29M05AT

MP-3Z (SC-63) (Unit: mm)



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### **RECOMMENDED SOLDERING CONDITIONS**

When soldering this product, it is highly recommended to observe the conditions as shown below. If other soldering processes are used, or if the soldering is performed under different condition, please make sure to consult with our sales offices.

For more details, refer to our document "SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL" (C10535E).

#### **Surface Mount Device**

 $\mu$ PC29M33AT,  $\mu$ PC29M05AT: MP-3Z (SC-63)

4U.com Process	Conditions	Symbol
Infrared Ray Reflow	Peak temperature: 235°C or below (Package surface temperature), Reflow time: 30 seconds or less (at 210°C or higher), Maximum number of reflow processes: 2 times or less.	IR35-00-2
Vapor Phase Soldering	Peak temperature: 215°C or below (Package surface temperature), Reflow time: 40 seconds or less (at 200°C or higher), Maximum number of reflow processes: 2 times or less.	VP15-00-2
Wave Soldering	Solder temperature: 260°C or below, Flow time: 10 seconds or less,  Maximum number of flow processes: 1 time,  Pre-heating temperature: 120°C or below (Package surface temperature).	WS60-00-1
Partial Heating Method	Pin temperature: 300°C or below, Heat time: 3 seconds or less (Per each side of the device).	-

Caution Apply only one kind of soldering condition to a device, except for "partial heating method", or the device will be damaged by heat stress.

Through-hole devices

μPC29M33AHF, μPC29M05AHF: MP-45G μPC29M33AHB, μPC29M05AHB: MP-3

Process	Conditions
Wave soldering	Solder temperature: 260°C or below,
(only to leads)	Flow time: 10 seconds or less.
Partial heating method	Pin temperature: 300°C or below,
	Heat time: 3 seconds or less (Per each pin).

Caution For through-hole device, the wave soldering process must be applied only to leads, and make sure that the package body does not get jet soldered.

### **NOTES ON USE**

When the  $\mu$ PC29M33A,  $\mu$ PC29M05A are used with an input voltage that is lower than the value indicated in the recommended operating conditions, a large quiescent current flows through the device due to saturation of the transistor of the output stage. (Refer to the IBIAS (IBIAS(S)) vs. VIN curves in **TYPICAL CHARACTERISTICS**). These products have saturation protector, but a current of up to 80 mA MAX. may flow through the device. Thus the power supply on the input side must have sufficient capacity to allow this quiescent current to pass when the device starts up.

#### REFERENCE DOCUMENTS

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4U.com	Document Name	Document No.		
QUALIT	TY GRADE ON NEC SEMICONDUCTOR DEVICES	C11531E		
SEMIC	SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL			
VOLTA	GE REGULATOR OF SMD	G11872E		
SEMIC	SEMICONDUCTOR SELECTION GUIDE – PRODUCTS AND PACKAGES			

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